

**Wire-wound Metal Power Inductors MCOIL™ LBDN series  
for Telecommunications Infrastructure and Industrial Equipment**  
**Wire-wound Metal Power Inductors MCOIL™ LMDN series  
for Medical Devices classified as GHTF Class C (Japan Class III)**

■ RELIABILITY DATA

1. Operating Temperature Range

Specified Value       $-40 \sim +125^{\circ}\text{C}$  (Including self-generated heat)

Test Methods  
and Remarks      Including self-generated heat

2. Storage Temperature Range

Specified Value       $-40 \sim +85^{\circ}\text{C}$

Test Methods  
and Remarks       $-5$  to  $40^{\circ}\text{C}$  for the product with taping.

3. Rated current

Specified Value      Within the specified tolerance

4. Inductance

Specified Value      Within the specified tolerance

Test Methods  
and Remarks      Measuring equipment      : LCR Meter (HP 4285A or equivalent)  
Measuring frequency      : 1MHz 1V (4040F:100kHz 1V)

5. DC Resistance

Specified Value      Within the specified tolerance

Test Methods  
and Remarks      Measuring equipment      : DC ohmmeter (HIOKI 3227 or equivalent)

6. Self resonance frequency

Specified Value      —

7. Temperature characteristic

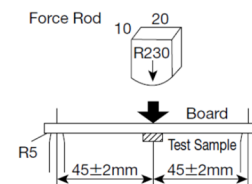
Specified Value      Inductance change : Within  $\pm 10\%$

Test Methods  
and Remarks      Measurement of inductance shall be taken at temperature range within  $-40^{\circ}\text{C} \sim +125^{\circ}\text{C}$ .  
With reference to inductance value at  $+20^{\circ}\text{C}$ ., change rate shall be calculated.

8. Resistance to flexure of substrate

Specified Value      No damage

Test Methods  
and Remarks      The test samples shall be soldered to the test board by the reflow. As illustrated below, apply force in the direction of the arrow indicating until deflection of the test board reaches to 2 mm.  
Test board size      :  $100 \times 40 \times 1.6$  mm  
Test board material      : glass epoxy-resin  
Solder cream thickness      : 0.10 mm



9. Insulation resistance : between wires

Specified Value      —

10. Insulation resistance : between wire and core

Specified Value      —

11. Withstanding voltage : between wire and core			
Specified Value	—		
12. Adhesion of terminal electrode			
Specified Value	Shall not come off PC board		
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. Applied force : 10N to X and Y directions. Duration : 5s. Solder cream thickness : 0.1mm.		
13. Resistance to vibration			
Specified Value	Inductance change : Within ±10% No significant abnormality in appearance.		
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. Then it shall be submitted to below test conditions.		
	Frequency Range	10~55Hz	
	Total Amplitude	1.5mm (May not exceed acceleration 196m/s²)	
	Sweeping Method	10Hz to 55Hz to 10Hz for 1min.	
	Time	X	For 2 hours on each X, Y, and Z axis.
		Y	
Z			
Recovery : At least 2hrs of recovery under the standard condition after the test, followed by the measurement within 48hrs.			
14. Solderability			
Specified Value	At least 90% of surface of terminal electrode is covered by new solder.		
Test Methods and Remarks	The test samples shall be dipped in flux, and then immersed in molten solder as shown in below table. Flux : Ethanol solution containing rosin 25%.		
	Solder Temperature	245±5℃	
	Time	5±1.0 sec.	
	※Immersion depth : All sides of mounting terminal shall be immersed.		
15. Resistance to soldering heat			
Specified Value	Inductance change : Within ±10% No significant abnormality in appearance.		
Test Methods and Remarks	The test sample shall be exposed to reflow oven at 230±5℃ for 40 seconds, with peak temperature at 260±5℃ for 5 seconds, 2 times. Test board material : glass epoxy-resin Test board thickness : 1.0mm		
16. Thermal shock			
Specified Value	Inductance change : Within ±10% No significant abnormality in appearance.		
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed at specified temperature for specified time by step 1 to step 4 as shown in below table in sequence. The temperature cycle shall be repeated 1000 cycles.		
	Conditions of 1 cycle		
	Step	Temperature (℃)	Duration (min)
	1	−40±3	30±3
	2	Room temperature	Within 3
	3	+85±2	30±3
	4	Room temperature	Within 3
17. Damp heat			
Specified Value	Inductance change : Within ±10% No significant abnormality in appearance.		
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity as shown in below table.		
	Temperature	60±2℃	
	Humidity	90~95%RH	
	Time	1000+24/−0 hour	

18. Loading under damp heat		
Specified Value	Inductance change : Within $\pm 10\%$ No significant abnormality in appearance.	
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and humidity and applied the rated current continuously as shown in below table.	
	Temperature	$60\pm 2^{\circ}\text{C}$
	Humidity	$90\sim 95\%\text{RH}$
	Applied current	Rated current
	Time	$1000+24/-0$ hour
19. Low temperature life test		
Specified Value	Inductance change : Within $\pm 10\%$ No significant abnormality in appearance.	
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. After that, the test samples shall be placed at test conditions as shown in below table.	
	Temperature	$-40\pm 2^{\circ}\text{C}$
	Time	$1000+24/-0$ hour
20. High temperature life test		
Specified Value	—	
21. Loading at high temperature life test		
Specified Value	Inductance change : Within $\pm 10\%$ No significant abnormality in appearance.	
Test Methods and Remarks	The test samples shall be soldered to the test board by the reflow. The test samples shall be placed in thermostatic oven set at specified temperature and applied the rated current continuously as shown in below table.	
	Temperature	$85\pm 2^{\circ}\text{C}$
	Applied current	Rated current
	Time	$1000+24/-0$ hour
	22. Standard condition	
Specified Value	Standard test condition :	
	Unless otherwise specified, temperature is $20\pm 15^{\circ}\text{C}$ and $65\pm 20\%$ of relative humidity.	
	When there is any question concerning measurement result: In order to provide correlation data, the test shall be condition of $20\pm 2^{\circ}\text{C}$ of temperature, $65\pm 5\%$ relative humidity.	
	Inductance is in accordance with our measured value.	